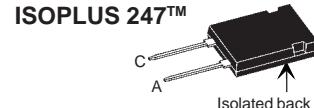
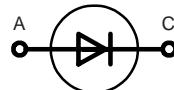


HiPerDynFRED™ Epitaxial Diode with soft recovery (Electrically Isolated Back Surface)

I_{FAV} = 30 A
V_{RRM} = 600 V
t_{rr} = 20 ns

V _{RSM} V	V _{RRM} V	Type
600	600	DSEP 30-06CR



A = Anode, C = Cathode

* Patent pending

Symbol	Conditions	Maximum Ratings		Features
I _{FRMS}		70	A	• Silicon chip on Direct-Copper-Bond substrates
I _{FAVM}	T _C = 135°C; rectangular, d = 0.5	30	A	- High power dissipation
I _{FRM}	t _p < 10 µs; rep. rating, pulse width limited by T _{VJM}	tbd	A	- Isolated mounting surface
I _{FSM}	T _{VJ} = 45°C; t _p = 10 ms (50 Hz), sine	300	A	- 2500 V electrical isolation
E _{AS}	T _{VJ} = 25°C; non-repetitive I _{AS} = 3 A; L = 180 µH	1.2	mJ	• Low cathode to tab capacitance (< 25 pF)
I _{AR}	V _A = 1.5·V _R typ.; f = 10 kHz; repetitive	0.3	A	• International standard package
T _{VJ}		-55...+175	°C	• Planar passivated chips
T _{VJM}		175	°C	• Very short recovery time
T _{stg}		-55...+150	°C	• Extremely low switching losses
P _{tot}	T _C = 25°C	250	W	• Low I _{RM} -values
V _{ISOL}	50/60 Hz RMS; I _{ISOL} ≤ 1 mA	2500	V~	• Soft recovery behaviour
F _c	mounting force with clip	20...120	N	• Epoxy meets UL 94V-0
Weight	typical	6	g	• Isolated and UL registered E153432

Symbol	Conditions	Characteristic Values		
		typ.	max.	
I _R ①	T _{VJ} = 25°C V _R = V _{RRM} T _{VJ} = 150°C V _R = V _{RRM}	250	µA	
		1	mA	
V _F ②	I _F = 30 A; T _{VJ} = 150°C T _{VJ} = 25°C	1.79	V	• Antiparallel diode for high frequency switching devices
		2.46	V	• Antisaturation diode
R _{thJC}		0.6	K/W	• Snubber diode
R _{thCH}	with heatsink compound	0.25	K/W	• Free wheeling diode in converters and motor control circuits and PFC circuits
t _{rr}	I _F = 1 A; -di/dt = 200 A/µs; V _R = 30 V; T _{VJ} = 25°C	20	ns	• Rectifiers in switch mode power supplies (SMPS)
I _{RM}	V _R = 100 V; I _F = 50 A; -di _F /dt = 100 A/µs T _{VJ} = 100°C	4.5	7.0	• Inductive heating
			A	• Uninterruptible power supplies (UPS)
				• Ultrasonic cleaners and welders

Pulse test: ① Pulse Width = 5 ms, Duty Cycle < 2.0 %
② Pulse Width = 300 µs, Duty Cycle < 2.0 %

Data according to IEC 60747 and per diode unless otherwise specified

Dimensions see Outlines.pdf

IXYS reserves the right to change limits, test conditions and dimensions

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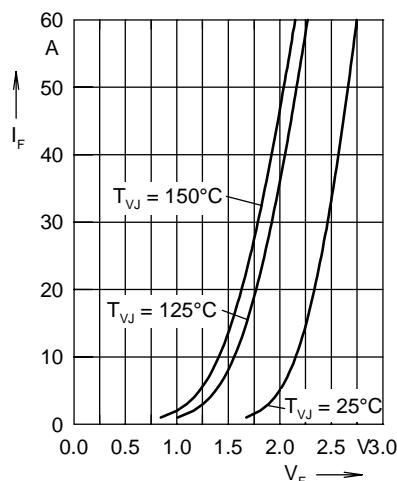


Fig. 1 Forward current I_F versus V_F

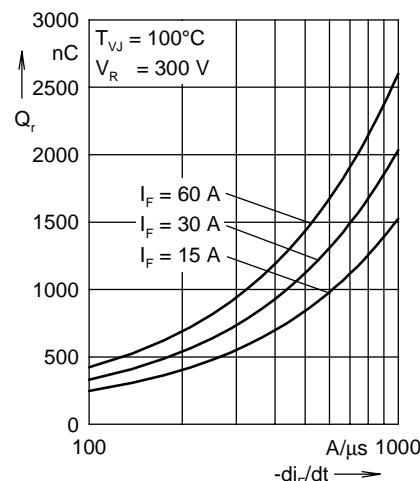


Fig. 2 Reverse recovery charge Q_r versus $-di_F/dt$

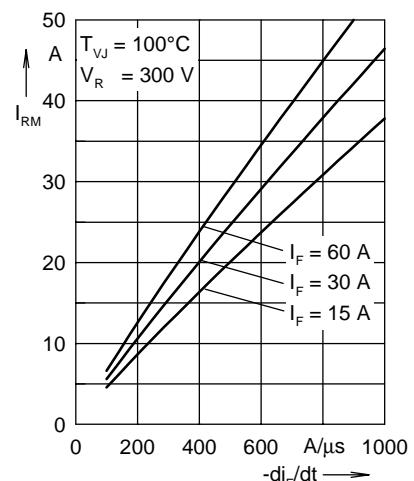


Fig. 3 Peak reverse current I_{RM} versus $-di_F/dt$

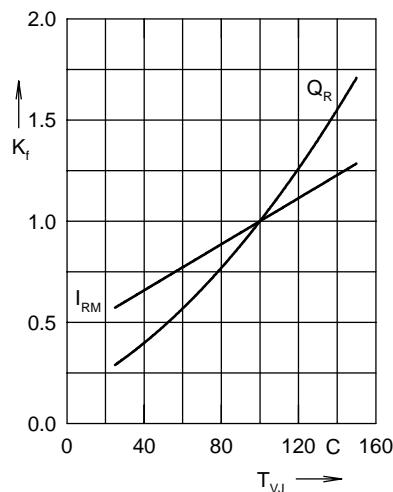


Fig. 4 Dynamic parameters Q_r , I_{RM} versus T_{VJ}

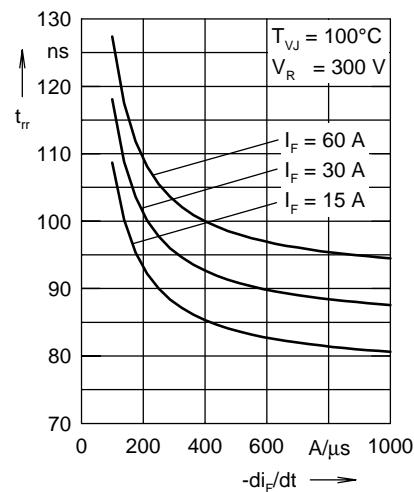


Fig. 5 Recovery time t_{rr} versus $-di_F/dt$

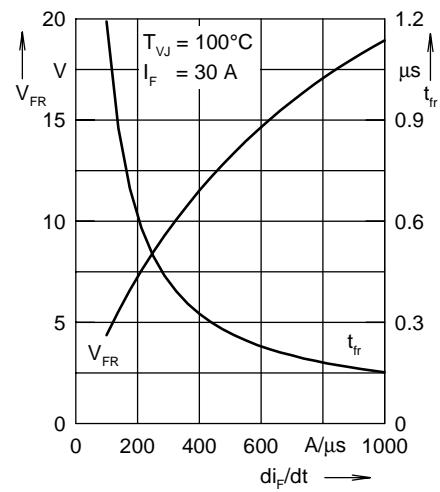


Fig. 6 Peak forward voltage V_{FR} and t_{fr} versus di_F/dt

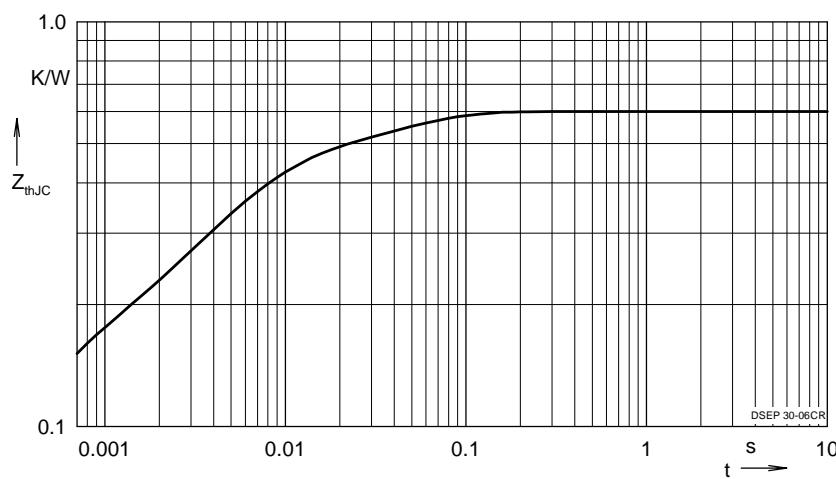


Fig. 7 Transient thermal resistance junction to case

Constants for Z_{thJC} calculation:

i	R_{thi} (K/W)	t_i (s)
1	0.31	0.005
2	0.1193	0.0003
3	0.1707	0.04